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# Imaging atomic-scale chemistry from fused multi-modal electron microscopy

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Efforts to map atomic-scale chemistry at low doses with minimal noise using electron microscopes are fundamentally limited by inelastic interactions. Here, fused multi-modal electron microscopy offers high signal-to-noise ratio (SNR) recovery of material chemistry at nano- and atomic-resolution by coupling correlated information encoded within both elastic scattering (high-angle annular dark-field (HAADF)) and inelastic spectroscopic signals (electron energy loss (EELS) or energy-dispersive x-ray (EDX)). By linking these simultaneously acquired signals, or modalities, the chemical distribution within nanomaterials can be imaged at significantly lower doses with existing detector hardware. In many cases, the dose requirements can be reduced by over one order of magnitude. This high SNR recovery of chemistry is tested against simulated and experimental atomic resolution data of heterogeneous nanomaterials.

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#### **INTRODUCTION**

Modern scanning transmission electron microscopes (STEM) can focus sub-angstrom electron beams on and between atoms to quantify structure and chemistry in real space from elastic and inelastic scattering processes. The chemical composition of specimens is revealed by spectroscopic techniques produced from inelastic interactions in the form of energy-dispersive X-rays (EDX)<sup>1,2</sup> or electron energy loss (EELS)<sup>3,4</sup>. Unfortunately, highresolution chemical imaging requires high doses (e.g., >10<sup>6</sup> e/Å<sup>2</sup>) that often exceed the specimen limits—resulting in chemical maps that are noisy or missing entirely<sup>5,6</sup>. Substantial effort and cost to improve detector hardware have brought the field closer to the measurement limits set by inelastic processes<sup>7,8</sup>. Direct interpretation of atomic structure at higher-SNR is provided by elastically scattered electrons collected in a high-angle annular dark-field detector (HAADF); however, this signal under-describes the chemistry<sup>9</sup>. Reaching the lowest doses at the highest SNR ultimately requires fusing both elastic and inelastic scattering modalities.

Currently, detector signals—such as HAADF and EDX/EELS—are analyzed separately for insight into structural, chemical, or electronic properties<sup>10</sup>. Correlative imaging disregards shared information between structure and chemistry and misses opportunities to recover useful information. Data fusion, popularized in satellite imaging, goes further than correlation by linking the separate signals to reconstruct new information and improve measurement accuracy<sup>11–13</sup>. Successful data fusion designs an analytical model that faithfully represents the relationship between modalities, and yields a meaningful combination without imposing any artificial connections<sup>14</sup>.

Here we introduce fused multi-modal electron microscopy, a technique offering high SNR recovery of nanomaterial chemistry

by linking correlated information encoded within both HAADF and EDX/EELS. We recover chemical maps by reformulating the inverse problem as a nonlinear optimization that seeks solutions that accurately match the actual chemical distribution in a material. Our approach substantially improves SNRs for chemical maps, often around 300–500%, and can reduce doses over one order of magnitude while remaining consistent with original measurements. We demonstrate EDX/EELS datasets at subnanometer and atomic resolution. Moreover, fused multi-modal electron microscopy recovers a specimen's relative concentration, allowing researchers to measure local stoichiometry with less than 15% error without any knowledge of the inelastic cross-sections. Convergence and uncertainty estimates are identified along with simulations that provide a ground-truth assessment of when and how this approach can fail.

#### **RESULTS**

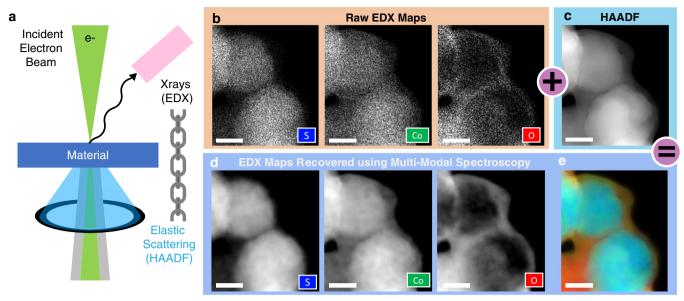
#### Principles of multi-modal electron microscopy

Fused multi-modal electron microscopy recovers chemical maps by solving an optimization problem seeking a solution that strongly correlates with (1) the HAADF modality containing high SNR, (2) the chemically sensitive spectroscopic modality (EELS and/or EDX), and (3) encourages sparsity in the gradient domain producing solutions with reduced spatial variation. The overall optimization function is as follows:

$$\underset{\boldsymbol{x}_{i} \geq 0}{\arg\min \frac{1}{2}} \left\| \boldsymbol{b}_{H} - \sum_{i} (Z_{i}\boldsymbol{x}_{i})^{\gamma} \right\|_{2}^{2} + \lambda_{1} \sum_{i} (\boldsymbol{1}^{T}\boldsymbol{x}_{i} - \boldsymbol{b}_{i}^{T} \log(\boldsymbol{x}_{i} + \varepsilon)) + \lambda_{2} \sum_{i} \|\boldsymbol{x}_{i}\|_{TV},$$
(1)

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**Fig. 1 Nanoscale multi-modal chemical recovery of CoS catalysts using EDX** + **HAADF. a** Schematic highlighting the linked HAADF and EDX modalities collected in the microscope for every probe position. The algorithm links and correlates information between the two signals through an optimization process that produces chemical maps with higher SNRs. **b** The raw EDX chemical maps for the Co, S, and O elemental distributions. **c** The simultaneous HAADF micrograph of the CoS nanoparticle. **d** The multi-modal reconstructions for the elemental distributions. **e** EDX RGB overlay of the Co, S, and O maps. Scale bar, 30 nm.

where  $\lambda$  are regularization parameters,  $\boldsymbol{b}_{H}$  is the measured HAADF,  $\boldsymbol{b}_{i}$  and  $\boldsymbol{x}_{i}$  are the measured and reconstructed chemical maps for element i,  $\varepsilon$  herein prevents log(0) issues but can also account for background, log is applied element-wise to its arguments, superscript T denotes vector transpose, and 1 denotes the vector of  $n_{x}n_{y}$  ones, where  $n_{x} \times n_{y}$  is the image size.

The three terms in Eq. (1) define our multi-modal approach to surpass traditional dose limits for chemical imaging. First, we assume a forward model where the simultaneous HAADF is a linear combination of elemental distributions ( $\mathbf{x}_{i}^{\gamma}$  where  $\gamma \in [1.4,$ 2]). The incoherent linear imaging approximation for elastic scattering scales with atomic number as  $Z_i^{\gamma}$  where  $\gamma$  is typically around  $1.7^{15-17}$ . This y is bounded between 2 for Rutherford scattering from bare nuclear potentials to 4/3 as described by Lenz-Wentzel expressions for electrons experiencing a screened Coulombic potential 18,19. Second, we ensure the recovered signals maintain a high degree of data fidelity with the initial measurements by using maximum negative log-likelihood for spectroscopic measurements dominated by low-count Poisson statistics<sup>20,21</sup>. In a higher count regime, this term can be substituted with a simple least-squares error. Lastly, we utilize channel-wise total variation (TV) regularization to enforce a sparse gradient magnitude, which reduces noise by promoting image smoothness while preserving sharp features<sup>22</sup>. This sparsity constraint, popularized by the field of compressed sensing (CS), is powerful yet minimal prior to recovering structured data<sup>23,24</sup>. When implementing, each of these three terms can and should be weighted by appropriately selected coefficients that balance their contributions. All three terms are necessary for accurate recovery (Supplementary Fig. 1).

#### High-SNR recovery of nanomaterial chemistry

Figure 1 demonstrates high-SNR recovery for EDX signals of commercial cobalt sulfide (CoS) nano-catalysts for oxygen-reduction applications—a unique class with the highest activity among non-precious metals<sup>25</sup>. Figure 1a illustrates the model that links the two modalities (EDX and HAADF) simultaneously collected in the electron microscope. The low detection rate for characteristic X-rays is due to minimal emission (e.g., over 50% for

Z>32 and below 2% for Z<11) and collection yield  $(<9\%)^{26}$ . For high-resolution EDX, the low count rate yields a sparse chemical image dominated by shot noise (Fig. 1b). However, noise in the fused multi-modal chemical map is virtually eliminated (Fig. 1d) and recovers chemical structure without a loss of resolution—including the nanoparticle core and oxide shell interface. The chemical maps produced by fused multi-modal EM quantitatively agree with the expected stoichiometry—the specimen core contains a relative concentration of  $39\pm1.6\%$ ,  $42\pm2.5\%$ , and  $13\pm2.4\%$  and exterior shell composition of  $26\pm2.8\%$ ,  $11\pm2.0\%$ ,  $54\pm1.3\%$  for Co, S, O, respectively. The dose for this dataset was  $\sim10^5$  e Å $^{-2}$  and a 0.7 sr EDX detector was used; however, these quantitative estimates remained consistent when the dose was reduced to  $\sim10^4$  e Å $^{-2}$ .

Fused multi-modal electron microscopy accurately recovers chemical structure down to atomic length scales—demonstrated here for EELS spectroscopic signals. EELS-derived chemical maps for  $Co_{3-x}Mn_xO_4$  (x = 1.49) high-performing super-capacitor nanoparticles are substantially improved by fused multi-modal electron microscopy in Fig. 2. This composite Co-Mn oxide was designed to achieve a synergy between cobalt oxide's high specific capacitance and manganese oxide's long life cycle 27,28. While the Co<sub>3-x</sub>Mn<sub>x</sub>O<sub>4</sub> nanoparticle appears chemically homogeneous in the HAADF projection image along the [100] direction (Fig. 2c), core-shell distinctions are hinted at in the raw EELS maps (Fig. 2b). Specifically, these nanoparticles contain an Mn-rich center with a Co shell and homogeneous distribution of O. However the raw EELS maps are excessively degraded by noise, preventing analysis beyond the rough assessment of specimen morphology. The multi-modal reconstructions (Fig. 2d) confirm the crystalline Corich shell and map the Co/Mn interface in greater detail (Fig. 2e). In the presence of cobalt and manganese, the HAADF image lacks noticeable contrast from oxygen; the resulting oxygen map lacks detail and benefits mostly from regularization.

Figure 3 exhibits fused multi-modal electron microscopy at an atomic resolution on copper–sulfur heterostructured nanocrystals with zinc sulfide caps with potential applications in photovoltaic devices or battery electrodes<sup>29</sup>. The copper sulfide properties are sensitive to the Cu–S stoichiometry and crystal structure at the

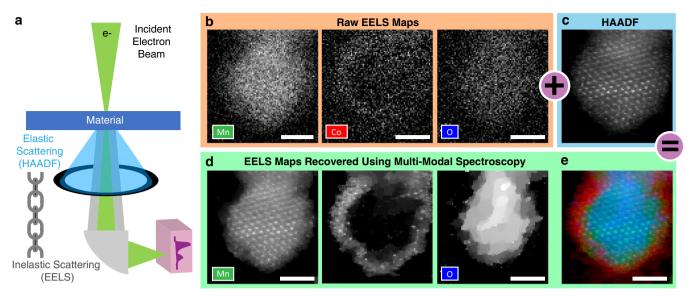


Fig. 2 Atomic-scale multi-modal chemical recovery of  $Co_{3-x}Mn_xO_4$  supercapacitors using EELS + HAADF. a Schematic highlighting the linked HAADF and EELS modalities collected in the microscope at every probe position. **b** Raw EELS maps for the elemental distributions of Co, Mn-L<sub>2,3</sub> and O–K edges. **c** The simultaneous HAADF micrograph of the  $Co_{3-x}Mn_xO_4$  nanoparticle. **d** The multi-modal reconstructions for the elemental distributions. **e** EELS RGB overlay of the Co, S, and O maps. Scale bar, 2 nm.

interface between ZnS and Cu<sub>0.64</sub>S<sub>0.36</sub>. Figure 3 shows high-resolution HAADF and EELS characterization of a heterostructure Cu<sub>0.64</sub>S<sub>0.36</sub>–ZnS interface. Fused multi-modal electron microscopy maps out the atomically sharp Cu<sub>0.64</sub>S<sub>0.36</sub>–ZnS interface and reveals step edges between the two layers. The labeled points on the RGB chemical overlay (Fig. 3d) show the chemical ratios produced by multi-modal EM for the Cu<sub>0.64</sub>S<sub>0.36</sub> and ZnS regions—values which are consistent with the reported growth conditions. Figure 3e shows the algorithm convergence for each of the three terms in the optimization function (Eq. (1))—smooth and asymptotic decay is an indicator of reliable reconstruction. Refer to Supplementary Fig. 2 for an additional demonstration at the atomic scale on an ordered manganite system.

Fused multi-modal imaging of Fe and Pt distributions from inelastic multislice simulations (Fig. 4) provide ground truth solutions to validate recovery at atomic resolution under multiple scattering conditions of an on-axis  $\sim$ 8 nm nanoparticle. Here, we applied Poisson noise (Fig. 4b) containing electron doses of  $\sim$ 109 e Å $^{-2}$ , to produce chemical maps with noise levels resembling experimental atomic-resolution EELS datasets (SNR  $\simeq$  5). We estimated SNR improvements by measuring peak-SNR for the noisy and recovered chemical maps $^{30}$ . Qualitatively, the recovered chemical distributions (Fig. 4c) match the original images. Figure 4d illustrates the agreement of the line profiles as the atom column positions and relative peak intensities between the ground truth and multi-modal reconstruction are almost identical.

Simulating EELS chemical maps is computationally demanding as every inelastic scattering event requires propagation of an additional wavefunction  $^{31,32}$ —scaling faster than the cube of the number of beams,  $O(N^3\log N)$ . Inelastic transition potentials of interest (in this case the  $L_{2,3}$  Fe and  $M_{4,5}$  Pt edges) were calculated from density function theory (see the "Methods" section). Long computation times (nearly 4000 core-hours) result from a large number of outgoing scattering channels corresponding to the many possible excitations in a sample. For this reason, there is little precedence for inelastic image simulations. We relaxed the runtime by utilizing the PRISM STEM-EELS approximation, achieving over a ten-fold speedup (see the "Methods" section)  $^{33}$ . Future work may explore the effects of smaller ADF collection angles with increased coherence lengths and crystallographic contrast  $^{15,34}$ , or

thicker specimens where electron channeling becomes more concerning<sup>35,36</sup>.

#### Quantifying chemical concentration

Fused multi-modal electron microscopy can produce stoichiometrically meaningful chemical maps without specific knowledge of inelastic cross-sections. Here, the ratio of pixel values in the reconstructed maps quantifies elemental concentration. We demonstrate quantifiable chemistry on experimental metal oxide thin films with known stoichiometry: NiO<sup>37</sup> and ZrO<sub>2</sub>. A histogram of intensities from the recovered chemical maps is fitted with Gaussian distributions to determine the average concentration. The recovered pixel values highlighted in Fig. 5 followed a single Gaussian distribution where the Zr and Ni concentrations are centered at about  $35 \pm 5.8\%$  and  $50 \pm 2.9\%$ . In both cases, the average Ni and Zr relative concentrations are approximately equivalent to the expected ratio from the crystal stoichiometry: 33% and 50%. The CoS nanoparticle in Fig. 1 follows a bi-modal distribution for the core and shell phases (Supplementary Fig. 5). We found measuring stoichiometry is robust across a range of y values close to 1.7. In cases where  $\gamma$  is far off (e.g.,  $\gamma = 1.0$ ), the quantification is systematically incorrect (Supplementary Fig. 6).

We further validate stoichiometric recovery on a synthetic gallium oxide crystal (Fig. 5) where two overlapping Ga and O thin films of equal thickness have a stoichiometery of  $\text{Ga}_2\text{O}_3$ . The simulated HAADF signal is proportional to  $\sum_i (\textbf{\textit{x}}_i Z_i)^{\gamma}$  where  $\textbf{\textit{x}}_i$  is the concentration for element i and  $Z_i$  is the atomic number. As shown by the histogram, the simulated results agree strongly with the prior knowledge and successfully recover the relative Ga concentration. The Gaussian distribution is centered about  $40 \pm 0.4\%$  when the ground truth is 40%. The inset shows convergence plots.

We estimate a stoichiometric error of <15% for most materials based on the relative concentration's standard deviation ( $\pm$ 7%) added in quadrature with the variation of solutions ( $\pm$ 6%). Although the algorithm shows stable convergence, the overall quantitative conclusions are slightly sensitive to the selection of hyperparameters. We estimate incorrect selection of hyperparameters could result in variation of roughly  $\pm$ 6% from the correct prediction in stoichiometry even when the algorithm converges (convergence shown in Supplementary Figs. 8 and 9). This error is



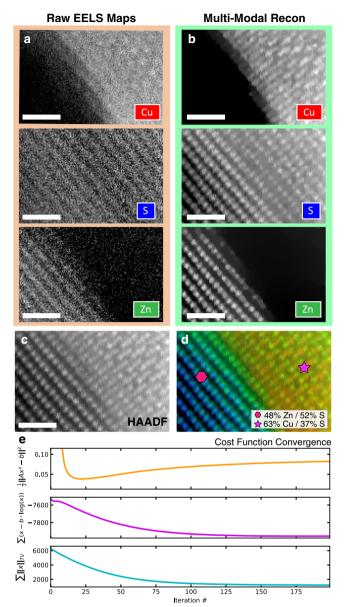
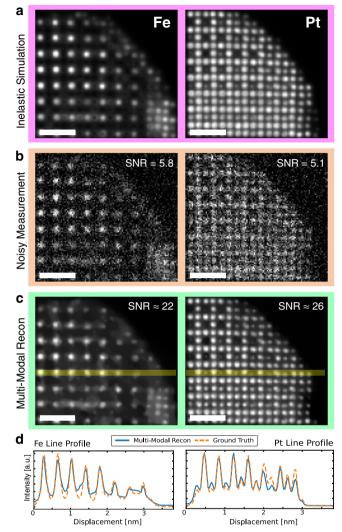


Fig. 3 Recovering chemistry in an atomically sharp ZnS-Cu<sub>0.64</sub>S<sub>0.36</sub> heterointerface interface. a The raw EELS maps for the Cu, S, and Zn L<sub>2,3</sub> edges. b The multi-modal reconstructions for the elemental compositions. c The simultaneous HAADF micrograph of the ZnS-Cu<sub>0.64</sub>S<sub>0.34</sub> interface. d Color overlay of the Zn, S, and Zn maps. The relative concentration for the constituent elements consists of  $48 \pm 5.9\%$  for Zn,  $59.9 \pm 3.2\%$  for Cu and  $38 \pm 2.6\%$  for S in the Cu<sub>0.64</sub>S<sub>0.36</sub> layer and  $48.9 \pm 6\%$  in ZnS. e Convergence plots for the three individual components in the cost function. Scale bar, 1 nm.

comparable to estimating chemical concentrations directly from EELS/EDX spectral maps from the ratio of scattering cross-section against core-loss intensity<sup>38</sup>. However, traditional approaches require accurate knowledge of all experimental parameters (e.g., beam energy, specimen-thickness, collection angles) and accurate calculation of the inelastic cross-section typically to provide errors roughly between 5% and 10%<sup>39</sup>.

#### Influence of electron dose

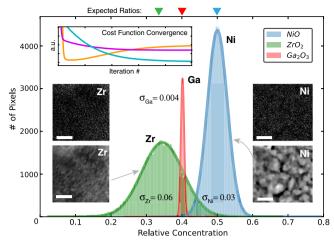
To better understand the accuracy of fused multi-modal electron microscopy at low doses, we performed a quantitative study of normalized root-mean-square error (RMSE) concentrations for a



**Fig. 4 Inelastic FePt nanoparticle simulation. a** Ground truth EELS images generated from inelastic simulations. **b** EELS maps degraded with Poisson shot noise. SNR is shown on the top right. **c** Recovered atomic-resolution EELS maps for the Fe and Pt distributions. Estimated SNR is shown on the top right. **d** Line profiles of the marked yellow bars (10 pixels in width) in (**c**) compares the multimodal reconstruction and ground truth. Scale bar, 1 nm.

simulated 3D core–shell nanoparticle (CoS core, CoO shell). Figure 6 shows the fused multi-modal reconstruction accuracy across a wide range of HAADF and chemical SNR. The simulated projection images were generated by a simple linear incoherent imaging model of the 3D chemical compositions highlighted in Fig. 6d—here the probe's depth of focus is much larger than the object. Random Poisson noise corresponding to different electron dose levels was applied to vary the SNR across each pixel.

Overall, the RMSE simulation map (Fig. 6a) shows the core–shell nanoparticle chemical maps are accurately recovered at low doses (HAADF SNR  $\gtrsim$  4 and chemical SNR  $\gtrsim$  2); however, they become less accurate at extremely low doses. The RMSE map for multimodal reconstruction shows a predictably continuous degradation in recovery as signals diminish. The degraded and reconstructed chemical maps for various noise levels are highlighted in Fig. 6b. The Co map closely mirrors the *Z*-contrast observed in HAADF (not shown) simply because it is the heaviest element present. Usually, researchers will perform spectroscopic experiments in the top right corner of Fig. 6a (e.g., HAADF



**Fig. 5 Measuring relative concentration for experimental and synthetic datasets.** Pixel intensity histograms for an experimental Zr (green), Ni (blue), and synthetic Ga (red) concentration maps. The standard deviation ( $\sigma$ ) for each element is reported. The raw and reconstructed EDX maps are illustrated inside of the plot. Ground truth concentrations are highlighted by the respective colored triangles above the top axis. Stable convergence for the three components in the cost function: model term (orange), data fidelity (magenta), and regularization (turquoise) are illustrated in the inset. Qualitatively the convergence is identical for all three example datasets. Zr and Ni scale bars: 5, 10 nm, respectively.

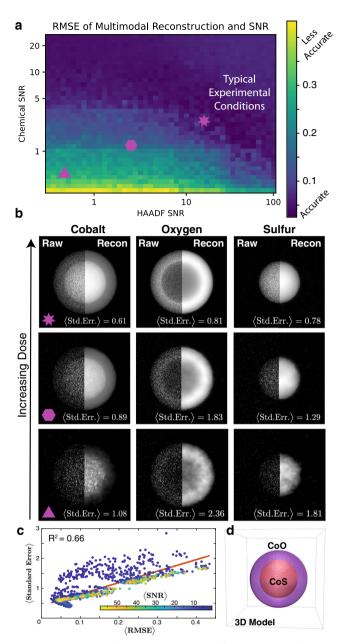
SNR > 20, chemical SNR > 3), which for this simulation, provides accurate recovery.

In actual experiments, the ground truth is unknown and RMSE cannot be calculated to assess fused multi-modal electron microscopy. However, we can estimate accuracy by calculating an average standard error of our recovered image from the Hessian of our model (see the "Methods" section). The standard error reflects uncertainty at each pixel in a recovered chemical map by quantifying the neighborhood size for similar solutions (Supplementary Fig. 10). The average standard error across all pixels in a fused multi-modal image provides a single value metric of the reconstruction accuracy (see the "Methods" section). Figure 6c shows that RMSE and average standard error correlate, especially at higher doses (SNR > 10).

#### **DISCUSSION**

While this paper highlights the advantages of multi-modal electron microscopy, the technique is not a black-box solution. Step sizes for convergence and weights on the terms in the cost function (Eq. (1)) must be reasonably selected. This manuscript illustrates approaches to assess the validity of concentration measurements using confidence estimation demonstrated across several simulated and experimental material classes. Standard spectroscopic pre-processing methods become ever more critical in combination with multi-modal fusion. Improper background subtraction of EELS spectra or overlapping characteristic X-ray peaks that normally cause inaccurate stoichiometric quantification also reduce the accuracy of fused multi-modal imaging.

Fused multi-modal electron microscopy offers little advantage in recovering chemical maps for elements with insignificant contrast in the HAADF modality. This property is limiting for analyzing specimens with low-Z elements in the presence of heavy elements (e.g., oxygen and lutetium). Future efforts could resolve this challenge by incorporating an additional complementary elastic imaging mode where light elements are visible, such as an annular bright-field (ABF)<sup>40</sup>. However, in some instances, fused multi-modal electron microscopy may recover useful information for under-determined chemical signals. For example, in a



**Fig. 6 Estimating dose requirements for accurate chemical recovery. a** A RMSE map representing the reconstruction error as a function of multiple spectroscopic and HAADF SNR. Brighter pixels denote results containing the incorrect concentrations from the ground truth. **b** Visualization of three points on the phase diagram corresponding to increasing ADF/chemical electron dose. **c** A plot of average standard error vs. RMSE demonstrating the two metrics are linearly correlated. **d** The 3D model for generating synthetic chemical and ADF projections.

Bi<sub>0.35</sub>Sr<sub>0.18</sub>Ca<sub>0.47</sub>MnO<sub>3</sub> (BSCMO) system<sup>41</sup>, only the Ca, Mn, and O EELS maps were obtained, yet multimodality remarkably improves the SNR of measured maps despite missing two elements (Supplementary Fig. 2).

Although fused multi-modal chemical mapping appears quite robust at nanometer or sub-nanometer resolution, we found atomic-resolution reconstructions can be challenged by spurious atom artifacts which require attention. However, this is easily remedied by down-sampling to frequencies below the first Bragg peaks and analyzing a lower resolution chemical map. Alternatively, recovery with minimal spurious atom artifacts is achieved

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when lower resolution reconstructions are used as an initial guess (Supplementary Fig. 11).

In summary, we present a model-driven data fusion algorithm that substantially improves the quality of electron microscopy spectroscopic maps at nanometer to atomic resolutions by using both elastic and inelastic signals. From these signals or modalities, each atom's chemical identity and coordination provides essential information about the performance of nanomaterials across a wide range of applications from clean energy, batteries, and optoelectronics, among many others. In both synthetic and experimental datasets, multi-modal electron microscopy shows quantitatively accurate chemical maps with values that reflect stoichiometry. This approach not only improves SNR but opens a pathway for lowdose chemical imaging of radiation-sensitive materials. Although demonstrated herein for common STEM detectors (HAADF, EDX, and EELS), this approach can be extended to many other modalities—including pixel array detectors, annular bright field, ptychography, low-loss EELS, etc. One can imagine a future where all scattered and emitted signals in an electron microscope are collected and fused for maximally efficiently atomic characterization of matter.

#### **METHODS**

#### **Electron microscopy**

Simultaneously acquired EELS and HAADF datasets were collected on a fifth-order aberration-corrected Nion UltraSTEM microscope operated at 100 keV with a probe semi-angle of roughly 30 mrad and collection semi-angle of 80–240 and 0–60 mrad for HAADF and EELS, respectively. Both specimens were imaged at 30 pA, for a dwell time of 10 ms (Fig. 3) and 15 ms (Fig. 2) receiving a total dose of  $3.25 \times 10^4$  and  $7.39 \times 10^4$  e/Ų. The EELS signals were obtained by integration over the core loss edges, all of which were done after background subtraction. The background EELS spectra were modeled using a linear combination of power laws implemented using the open-source Cornell Spectrum Imager software<sup>6</sup>.

Simultaneously acquired EDX and HAADF datasets were collected on a Thermo Fisher Scientific Titan Themis G2 at 200 keV with a probe semi-angle of roughly 25 mrad, HAADF collection semi-angle of 73–200 mrad, and 0.7 sr EDX solid angle. The CoS specimen was imaged at 100 pA and 40  $\mu$ s dwell time for 50 frames receiving a total dose of ~2 × 10<sup>5</sup> e/Ų. The initial chemical distributions were generated from EDX maps using commercial Velox software that produced initial net count estimates (however atomic percent estimates are also suitable).

#### Fused multi-modal recovery

Here, fused multi-modal electron microscopy is framed as an inverse problem expressed in the following form:  $\hat{\pmb{x}} = \arg\min_{{\pmb{w}}} \Psi_1({\pmb{x}}) + \lambda_1 \Psi_2({\pmb{x}})$ 

 $+\lambda_2 \text{TV}(\boldsymbol{x})$ , where  $\hat{\boldsymbol{x}}$  is the final reconstruction, and the three terms are described in the main manuscript (Eq. (1)). When implementing an algorithm to solve this problem, we concatenate the multi-element spectral variables  $(\boldsymbol{x}_i, \boldsymbol{b}_i)$  as a single vector:  $\boldsymbol{x}, \boldsymbol{b} \in \mathbb{R}^{n_x n_y n_i}$ , where  $n_i$  denotes the total number of reconstructed elements.

The optimization problem is solved by a combination of gradient descent with total variation regularization. We solve this cost function by descending along with the negative gradient directions for the first two terms and subsequently evaluate the isotropic TV proximal operator to denoise the chemical maps<sup>42</sup>. The gradients of the first two terms are:

$$\nabla_{\boldsymbol{x}}\Psi_{1}(\boldsymbol{x}) = -\gamma\operatorname{diag}\left(\boldsymbol{x}^{\gamma-1}\right)\boldsymbol{A}^{T}(\boldsymbol{b}_{H}-\boldsymbol{A}\boldsymbol{x}^{\gamma}) \tag{2}$$

$$\nabla_{\mathbf{x}}\Psi_{2}(\mathbf{x}) = \mathbf{1} - \mathbf{b} \oslash (\mathbf{x} + \mathbf{\epsilon}), \tag{3}$$

where  $\oslash$  denotes point-wise division. Here, the first term in the cost function, relating the elastic and inelastic modalities, has been equivalently re-written as  $\Psi_1 = \frac{1}{2} \| \boldsymbol{b}_H - \boldsymbol{A} \boldsymbol{x}^V \|_2^2$ , where  $\boldsymbol{A} \in \mathbb{R}^{n_L n_V \times n_L n_V n_l}$  expresses the summation of all elements as matrix-vector multiplication. Evaluation for the TV proximal operator is in itself another iterative algorithm. In addition, we impose a non-negativity constraint since negative concentrations are unrealistic. We initialize the first iterate with the measured data  $(\boldsymbol{x}_i^0 = \boldsymbol{b}_i)$ , an ideal starting point as it is a local minima for  $\Psi_2$ .

The inverse of the Lipschitz constant (1/L) is an upper bound of the step size that can theoretically guarantee convergence. From Lipschitz

continuity, we estimated the step size for the model term's gradient  $(\nabla \Psi_1)$  as  $1/L_{\nabla \Psi_1} \leq 1/\left(\|\mathbf{A}\|_1\|\mathbf{A}\|_{\infty}\right) = 1/n_i$ . The gradient of the Poisson negative log-likelihood  $(\Psi_2)$  is not Lipschitz continuous, so its descent parameter cannot be pre-computed<sup>43</sup>. We heuristically determined the regularization parameters starting with values with a similar order of magnitude to  $1/L_{\nabla \Psi_1}$ , then iteratively reduce until the cost function exhibits stable convergence. The regularization parameters were manually selected, however, future work may allow automated optimization by the L-curve method or cross-validation<sup>44</sup>.

#### Estimating standard error of recovered chemical maps

Using estimation theory, we can approximate the uncertainty in a recovered chemical image for unbiased estimators with the model's (Eq. (1)) Hessian expressed as:  $\mathbf{H}(\mathbf{x}) = \nabla_{\mathbf{x}}^2 \Psi_1(\mathbf{x}) + \nabla_{\mathbf{x}}^2 \Psi_2(\mathbf{x})$ , where

$$\nabla_{\mathbf{x}}^{2} \Psi_{1}(\mathbf{x}) = \operatorname{diag}\left(\gamma(\gamma - 1)\operatorname{diag}\left(\mathbf{x}^{\gamma - 2}\right)\mathbf{A}^{\mathsf{T}}(\mathbf{b}_{\mathsf{H}} - \mathbf{A}\mathbf{x}^{\gamma})\right) + \gamma^{2}\operatorname{diag}\left(\mathbf{x}^{\gamma - 2}\right)\mathbf{A}^{\mathsf{T}}\mathbf{A}\operatorname{diag}\left(\mathbf{x}^{\gamma - 1}\right)$$
(4)

$$\nabla_{\mathbf{x}}^{2}\Psi_{2}(\mathbf{x}) = \operatorname{diag}\left(\mathbf{b} \oslash (\mathbf{x} + \mathbf{\varepsilon})^{2}\right)$$
 (5)

Calculation of standard error follows the Cramer–Rao inequality, which provides a lower bound given by:  $\left(\mathbf{Var}(\hat{x}_j) \geq [\mathbf{H}^{-1}(\hat{\mathbf{x}})]_{jj}\right)^{45}$ , where  $\mathbf{Var}(\hat{\mathbf{x}})$  are variance maps for the recovered chemical distributions  $(\hat{\mathbf{x}})$  and subscript jj denotes indices along with the diagonal elements. We determined this lower bound from an empirical derivation of the Fisher Information Matrix. From the variance, we thus extract standard error maps: **Standard Error** =  $\sqrt{\mathbf{Var}(\hat{\mathbf{x}})}$  as demonstrated in Supplementary Fig. 10. The average standard error denotes the mean value of all pixels in **Standard Error**. Note, the TV regularizer reduces noise and may introduce bias due to smoothing, so the standard error measurements could potentially be lower; our Fisher information derivation provides an upper bound on uncertainty.

#### Inelastic scattering simulations for atomic imaging

The inelastic scattering simulations for the FePt nanoparticle structure (Fig. 4) were performed using the abTEM simulation code<sup>46</sup>, using the algorithm described in ref. <sup>33</sup>. In this algorithm, the initial STEM probe is propagated and transmitted to some depth into the specimen using the scattering matrix method described in the PRISM algorithm<sup>47</sup>. Next, the inelastic transition potentials of interest (in this case the  $L_{2,3}$  Fe and  $M_{4,5}$  Pt edges) were calculated and applied using the methods given in refs. <sup>48,49</sup>, using the GPAW density functional theory code<sup>50</sup>. Finally, a second scattering matrix is used to propagate the inelastically scattered electrons through the sample and to the plane of the EELS entrance aperture. The elastic signal channels were calculated with the conventional PRISM method using the same parameters.

The atomic structure used in the simulations was a portion of the FePt nanoparticle structure determined from atomic electron tomography<sup>51</sup>. After cropping out 1/4 of nanoparticle coordinates, the boundaries were padded by 5 Å total vacuum. The STEM probe's convergence semiangle was set to 20 mrad and the voltage to 200 kV. The multislice steps used slice thicknesses of 2 Å, the wavefunction sampling size was 0.15 Å, and the projected potentials were computed using the infinite Kirkland parameterization<sup>52</sup>. The EELS detector had a semiangle of 30 mrad, and the STEM probe positions were Nyquist sampled at a step size of 0.31 Å. After completion, we convolved the simulated images with a 0.2 Å Gaussian to account for source size. These simulation parameters required ~4 days of calculation time using the CPU mode of abTEM on a workstation with a 40 core Xeon processor clocked at 2.0 GHz.

#### **DATA AVAILABILITY**

The datasets and codes that support the finding of this study are available from the corresponding author upon reasonable request.

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#### **REFERENCES**

 D'Alfonso, A., Freitag, B., Klenov, D. & Allen, L. Atomic-resolution chemical mapping using energy-dispersive x-ray spectroscopy. Phys. Rev. B 81, 100101 (2010).

np)

- Kothleitner, G. et al. Quantitative elemental mapping at atomic resolution using x-ray spectroscopy. Phys. Rev. Lett. 112, 085501 (2014).
- 3. Spence, J. & Lynch, J. Stem microanalysis by transmission electron energy loss spectroscopy in crystals. *Ultramicroscopy* **9**, 267–276 (1982).
- Muller, D. et al. Atomic-scale chemical imaging of composition and bonding by aberration-corrected microscopy. Science 319, 1073–1076 (2008).
- Hart, J. L. et al. Direct detection electron energy-loss spectroscopy: a method to push the limits of resolution and sensitivity. Sci. Rep. 7, 1–14 (2017).
- Cueva, P., Hovden, R., Mundy, J., Xin, H. & Muller, D. Data processing for atomic resolution electron energy loss spectroscopy. *Microsc. Microanal.* 18, 667–675 (2012)
- McMullan, G., Faruqi, A., Clare, D. & Henderson, R. Comparison of optimal performance at 300kev of three direct electron detectors for use in low dose electron microscopy. *Ultramicroscopy* 147, 156–163 (2014).
- Kotula, P., Klenov, D. & Harrach, S. Challenges to quantitative multivariate statistical analysis of atomic-resolution x-ray spectral. *Microsc. Microanal.* 18, 691–698 (2012)
- LeBeau, J. M., Findlay, S. D., Allen, L. J. & Stemmer, S. Quantitative atomic resolution scanning transmission electron microscopy. *Phys. Rev. Lett.* 100, 206101 (2008).
- Su, Y. et al. Multi-dimensional correlative imaging of subcellular events: combining the strengths of light and electron microscopy. Biophys. Rev. 2, 121–135 (2010).
- Hall, D. L. & Llinas, J. An introduction to multisensor data fusion. Proc. IEEE 85, 6–23 (1997).
- Lahat, D., Adali, T. & Jutten, C. Multimodal data fusion: an overview of methods, challenges, and prospects. *Proc. IEEE* 103, 1449–1477 (2015).
- Di, Z. W., Leyffer, S. & Wild, S. Optimization-based approach for joint x-ray fluorescence and transmission tomographic inversion. SIAM J. Imaging Sci. 9, 1–23 (2016).
- Calhoun, V. & Sui, J. Multimodal fusion of brain imaging data: a key to finding the missing link(s) in complex mental illness. *Biol. Psychiatry* 1, 230–244 (2016).
- Hartel, P., Rose, H. & Dinges, C. Conditions and reasons for incoherent imaging in stem. *Ultramicroscopy* 63, 93–114 (1996).
- Krivanek, O. L. et al. Atom-by-atom structural and chemical analysis by annular dark-field electron microscopy. *Nature* 464, 571–574 (2010).
- Hovden, R. & Muller, D. A. Efficient elastic imaging of single atoms on ultrathin supports in a scanning transmission electron microscope. *Ultramicroscopy* 123, 59–65 (2012)
- Crewe, A., Wall, J. & Langmore, J. Visibility of single atoms. Science 168, 1338–1340 (1970).
- Wall, J., Isaacson, M. & Langmore, J. The collection of scattered electrons in dark field electron microscopy. *Optik* 39, 359–374 (1974).
- Di, Z. W. et al. Joint reconstruction of x-ray fluorescence and transmission tomography. *Opt. Express* 25, 13107–13124 (2017).
- Odstrčil, M., Menzel, A. & Guizar-Sicairos, M. Iterative least-squares solver for generalized maximum-likelihood ptychography. *Opt. Express* 26, 3108–3123 (2018).
- Rudin, L., Osher, S. & Fatemi, E. Nonlinear total variation based noise removal algorithms. *Physica D* 60, 259–268 (1992).
- 23. Donoho, D. Compressed sensing. IEEE Trans. Inf. Theory 52, 1289–1306 (2006).
- Candès, E., Romberg, J. & Tao, T. Robust uncertainty principles: exact signal reconstruction from highly incomplete frequency information. *IEEE Trans. Inf.* Theory 52, 489–509 (2006).
- Rozeveld, S., Lee, W.-S. & Longo, P. Characterization of cobalt sulfide catalysts. Microsc. Microanal. 26, 1248–1250 (2020).
- Schlossmacher, P., Klenov, D., Freitag, B. & von Harrach, H. Enhanced detection sensitivity with a new windowless XEDS system for AEM based on silicon drift detector technology. *Microsc. Today* 18, 14–20 (2010).
- Perera, S. et al. Enhanced supercapacitor performance for equal co-mn stoichiometry in colloidal Co<sub>3-x</sub>Mn<sub>x</sub>O<sub>4</sub> nanoparticles, in additive-free electrodes. Chem. Mater. 27, 7861–7873 (2015).
- Bhargava, A. et al. Mn cations control electronic transport in spinel Co<sub>x</sub>Mn<sub>3-x</sub>O<sub>4</sub> nanoparticles. Chem. Mater. 31, 4228–4233 (2019).
- Ha, D.-H. et al. Solid-solid phase transformations induced through cation exchange and strain in 2d heterostructured copper sulfide nanocrystals. *Nano Lett.* 14, 7090–7099 (2014).
- Horé, A. & Ziou, D. Image quality metrics: PSNR and SSIM. In 2010 20th International Conference on Pattern Recognition, (ed. Ercil, A.) 2366–2369 (IEEE, 2010).
- Dwyer, C. The role of symmetry in the theory of inelastic high-energy electron scattering and its application to atomic-resolution core-loss imaging. *Ultra*microscopy 151, 68–77 (2015).
- Allen, L. J. et al. Modelling the inelastic scattering of fast electrons. Ultramicroscopy 151, 11–22 (2015).
- Brown, H., Ciston, J. & Ophus, C. Linear-scaling algorithm for rapid computation of inelastic transition of multiple electron scattering. *Phys. Rev. Res.* 1, 033186 (2019).

- Zhang, Z., De Backer, A., Lobato, I., Van Aert, S. & Nellist, P. Combining ADF-EDX scattering cross-sections for elemental quantification of nanostructures. *Microsc. Microanal.* 27, 600–602 (2021).
- Anstis, G., Cai, D. & Cockayne, D. Limitations on the s-state approach to the interpretation of sub-angstrom resolution electron microscope images and microanalysis. *Ultramicroscopy* 94, 309–327 (2003).
- Hovden, R., Xin, H. L. & Muller, D. A. Channeling of a subangstrom electron beam in a crystal mapped to two-dimensional molecular orbitals. *Phys. Rev. B* 86, 195415 (2012).
- Egerton, R. & Cheng, S. Characterization of an analytical electron microscope with a NiO test specimen. *Ultramicroscopy* 55, 43–54 (1994).
- Rez, P. Cross-sections for energy loss spectroscopy. Ultramicroscopy 9, 283–288 (1982).
- 39. Egerton, R. Formulae for light-element microanalysis by electron energy-loss spectrometry. *Ultramicroscopy* **3**, 243–251 (1978).
- 40. Findlay, S. et al. Dynamics of annular bright field imaging in scanning transmission electron microscopy. *Ultramicroscopy* **110**, 903–923 (2010).
- 41. Savitzky, B. et al. Bending and breaking of stripes in charge ordered manganite. *Nat. Commun.* **8**, 1883 (2017).
- Beck, D. & Teboulle, M. Fast gradient-based algorithms for constrained total variation image denoising and deblurring problems. *IEEE Trans. Image Proc.* 18, 2419–2434 (2009).
- Dupé, F.-X., Fadili, J. & Starck, J.-L. A proximal iteration for deconvolving Poisson noisy images using sparse representations. *IEEE Trans. Image Proc.* 18, 310–321 (2009).
- Vogel, C. Computational Methods for Inverse Problems, chap 7, 97–127 (SIAM, 2002).
- Wei, X., Urbach, H. P. & Coene, W. Cramér–Rao lower bound and maximumlikelihood estimation in ptychography with Poisson noise. *Phys. Rev. A* 102, P043516 (2020).
- Madsen, J. & Susi, T. The abTEM code: transmission electron microscopy from first principles. *Open Res. Eur.* 1, 1–24 (2021).
- 47. Ophus, C. A fast image simulation algorithm for scanning transmission electron microscopy. *Adv. Struct. Chem. Imaa.* **3.** 13 (2017).
- 48. Saldin, D. & Rez, P. The theory of the excitation of atomic inner-shells in crystals by fast electrons. *Philos. Mag. B* **55**, 481–489 (1987).
- Dwyer, C., Findlay, S. & Allen, L. Multiple elastic scattering of core-loss electrons in atomic resolution imaging. *Phys. Rev. B* 100, 206101 (2008).
- Enkovaara, J. et al. Electronic structure calculations with GPAW: a real-space implementation of the projector augmented-wave method. J. Phys.: Condens. Matter 22, 253202 (2010).
- 51. Yang, Y. et al. Deciphering chemical order/disorder and material properties at the single-atom level. *Nature* **542**, 75–79 (2017).
- 52. Kirkland, E. Advanced Computing in Electron Microscopy (Springer Nature, 2010).

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#### **AUTHOR CONTRIBUTIONS**

J.S., R.H., Z.W.D., and Y.J. conceived the idea. J.S. and R.H. implemented the multimodal reconstruction algorithms and performed the analysis. J.F. and Z.W.D. assisted with the algorithm formulation. C.O. designed and ran the inelastic multi-slice simulations. S.R. and A.J.F. conducted the EDX experiments. R.H. and I.E.B. conducted the ELS experiments. R.R., D. H., S.D.P., synthesized the  $\text{Co}_{3-x}\text{Mn}_x\text{O}$  and ZnSCu nanoparticles. J.S. and R.H. wrote the manuscript. All authors reviewed and commented on the manuscript.

#### **COMPETING INTERESTS**

The authors declare no competing interests.

#### ADDITIONAL INFORMATION

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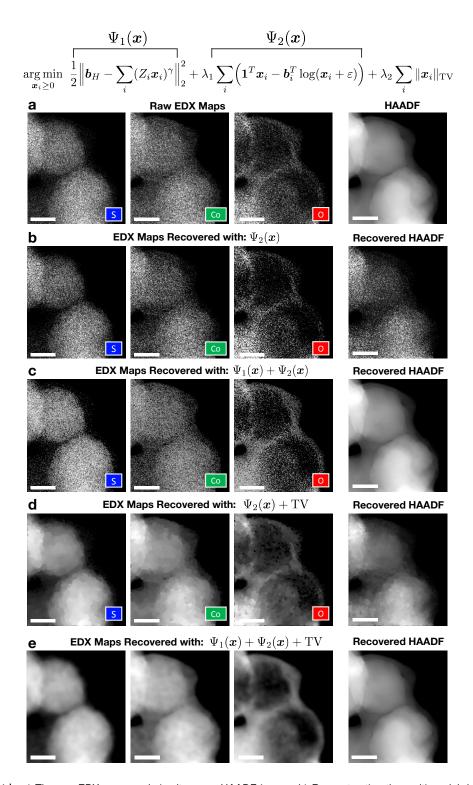
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## **Supplementary Information for**

## **Imaging Atomic-Scale Chemistry from Fused Multi-Modal Electron Microscopy**

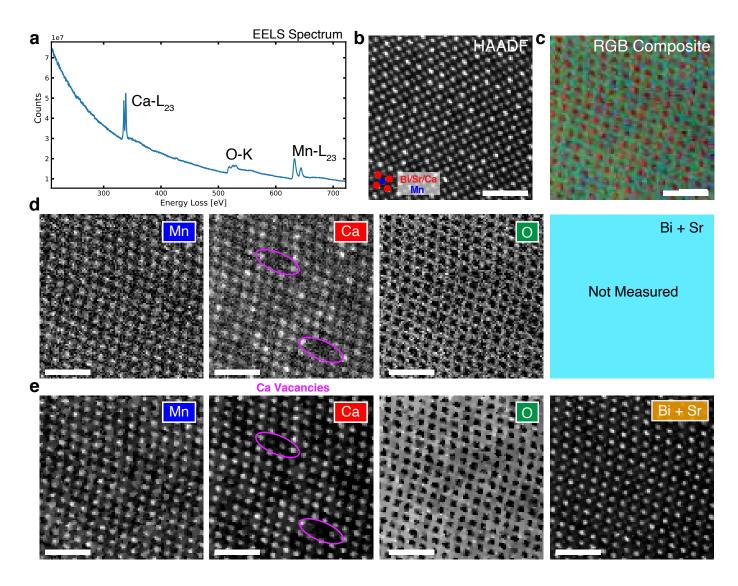
Jonathan Schwartz, Zichao Wendy Di, Yi Jiang, Alyssa J. Fielitz, Don-Hyung Ha, Sanjaya D. Perera, Ismail El Baggari, Richard D. Robinson, Jeffrey A. Fessler, Colin Ophus, Steve Rozeveld, and Robert Hovden

# 1 Consequence of Reconstructing Chemical Maps with Individual Components in Cost Function



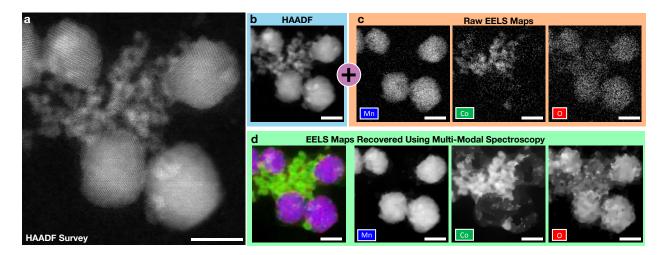
Supplementary Figure 1 | a) The raw EDX maps and simultaneous HAADF image. b) Reconstructing the multi-modal dataset with only  $\Psi_2$  (data-consistency). The recovered chemical maps and HAADF are noisy. c) Reconstructing the multi-modal dataset with  $\Psi_1 + \Psi_2$  (model + data-consistency). The chemical maps are slightly improved but remain noisy. d) Reconstructing the multi-modal dataset with  $\Psi_2 + TV$ . This functional form is equivalent to a denoising problem; thus the resulting maps produce common staircase artifacts associated with TV [1]. e) Reconstructing the raw EDX maps with fused Multi-Modal Electron Microscopy. Scale bar, 30 nm.

## 2 Recovering Missing Elements for $Bi_{0.35}Sr_{0.18}Ca_{0.47}MnO_3$ (BSCMO)



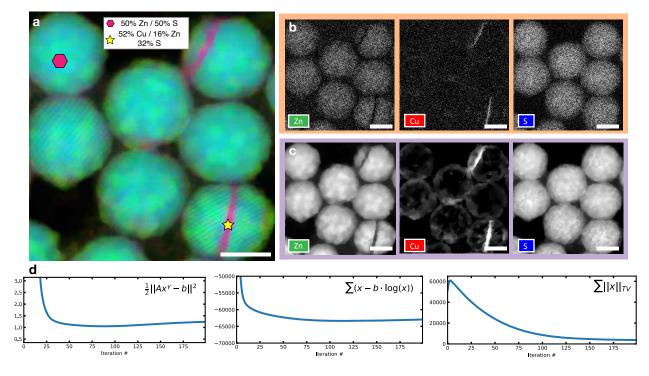
Supplementary Figure 2 | a) Raw EELS spectrum for a BSCMO system shows Ca, O, and Mn core-loss edges, however, the Bi and Sr core edges were not measured in this energy range. b) The simultaneously collected HAADF image with the inset on the bottom right highlighting the A and B sites' composition. c) RGB overlay highlighting the chemical distribution. d) The raw EELS maps. e) The recovered chemical maps. The purple circles highlight Ca vacancies. Here, the Bi and Sr were treated as a single unknown signal since they are known a priori to occupy the same lattice sites. Although chemical maps of Bi and Sr are missing, multi-modal reconstruction shows considerable improvement to the SNR and quality of the Mn, Ca, and O distributions. Moreover, we see the recovered Bi + Sr map anti-correlates with Ca as expected, however the small intensity between lattice sites is a minor artifact that arises without spectroscopic measurement of Bi and Sr. Scale bar, 2 nm.

## 3 Nanoscale Reconstruction of $Co_{3-x}Mn_xO_4$ nanoparticles



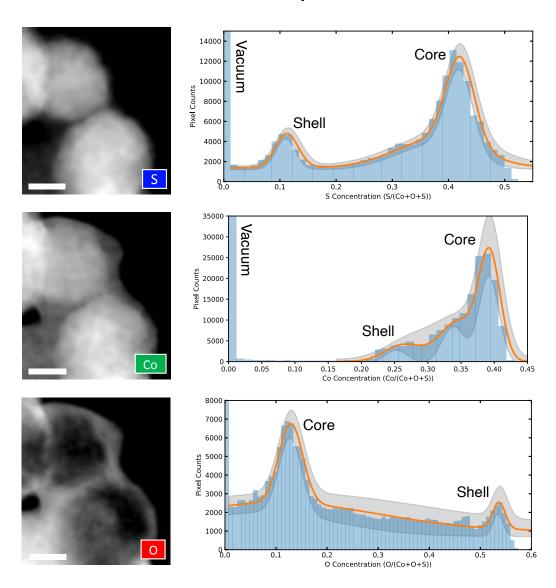
**Supplementary Figure 3** | a) HAADF survey image of the nanoparticles confirming that both the CoO and MnO nanoparticles are indeed crystalline. b-c) The simultaneous HAADF and raw EELS maps of the nanoparticles. d) An RGB chemical overlay and constituent recovered maps for Mn, Co, and O distributions. Scale bar, 5 nm.

## 4 Nanoscale Reconstruction of ZnSCu nanoparticles



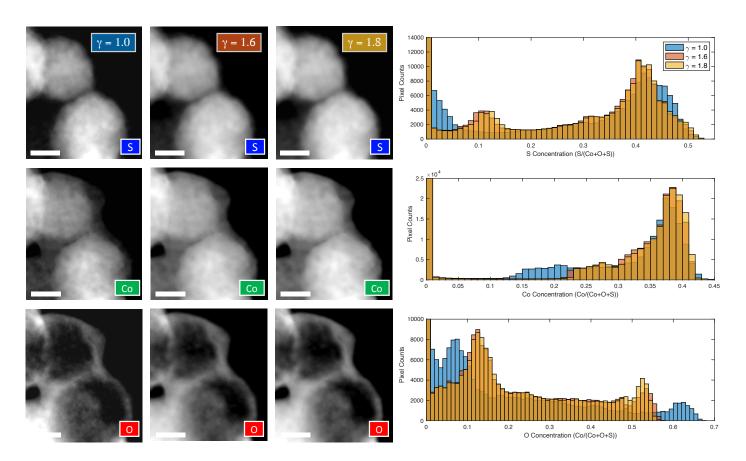
Supplementary Figure 4 | a) An RGB chemical overlay for the Zn, Cu, and S distributions. The two points labeled in the white box reports concentrations for the three elements. b-c) The raw EELS maps and multi-modal reconstructions. d) Convergence plots for the three components in the cost function: model based term, data fidelity, and regularization. Scale bar, 10 nm.

## 5 Histograms of intensities for CoS chemical Maps



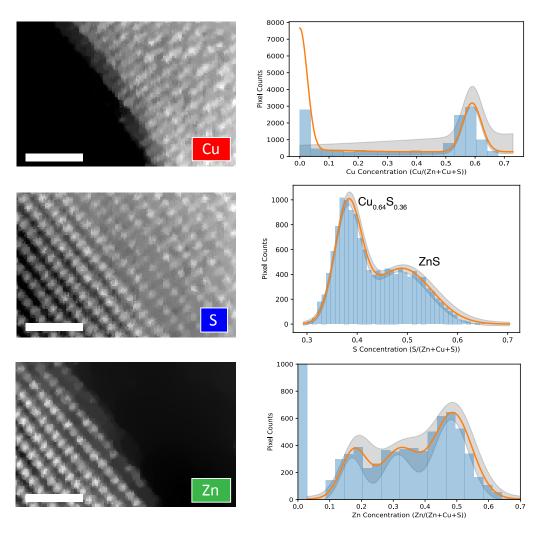
**Supplementary Figure 5** | Histogram of intensities for the Sulphur, Cobalt and Oxygen distributions. Due to the core-shell structure consisting of two phases, the histograms contain of two Gaussian distributions. The specimen core contains a relative concentration of 39±1.6%, 42±2.5% and 13±2.4% and exterior shell composition of 26±2.8%, 11±2.0%, 54±1.3% for Co, S, O respectively. Scale bar, 30 nm.

## 6 The influence of $\gamma$ for measuring chemistry



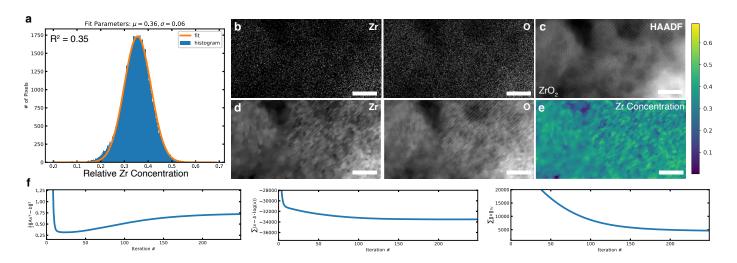
Supplementary Figure 6 | Histogram of intensities for the Sulphur, Cobalt and Oxygen distributions when  $\gamma$  varies between 1.0, 1.6, and 1.8. We see for values close to 1.7, the specimen's relative concentrations almost perfectly matches the distribution in Fig. S5. However if gamma is far off from what is experimentally feasible ( $\gamma = 1.0$ ), the measured concentrations are incorrect. Scale bar, 30 nm.

## 7 Histograms of intensities for ZnSCu chemical Maps



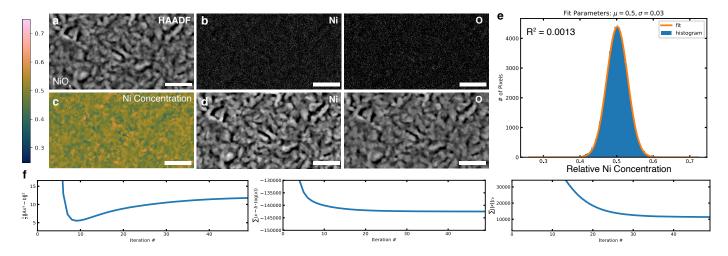
**Supplementary Figure 7** Histogram of intensities for the Sulphur, Cobalt and Oxygen distributions. Due to the core-shell structure consisting of two phases, the histograms contain of two Gaussian distributions. The specimen core contains a relative concentration of 39±1.6%, 42±2.5% and 13±2.4% and exterior shell composition of 26±2.8%, 11±2.0%, 54±1.3% for Co, S, O respectively. Scale bar, 1 nm.

## 8 ZrO<sub>2</sub> Reconstruction



**Supplementary Figure 8** | a) Histogram of intensities for the Zr distribution for a sputtered  $ZrO_2$  thin film. The fit parameters and  $R^2$  values for this Gaussian are reported. b-c) The raw EDX maps and simultaneous HAADF for the Zr and Oxygen distribution. d-e) The multi-modal reconstructions for the constituent elements and Zr concentration map. f) Convergence plots for each term in the cost function. Scale bar, 5 nm.

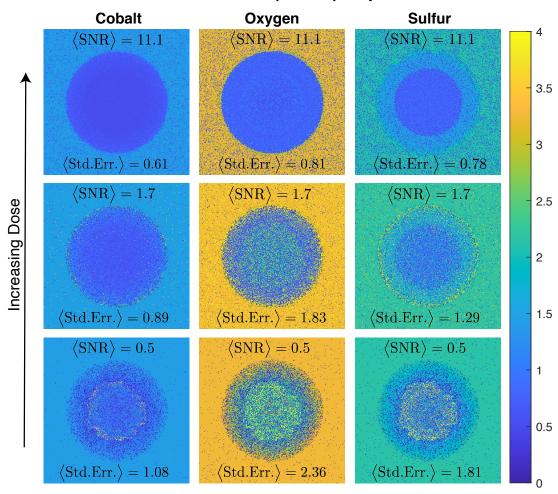
#### 9 NiO Reconstruction



**Supplementary Figure 9** a-b) The raw EDX maps and simultaneous HAADF for the nickel and oxygen distribution. c-d) The multi-modal reconstructions for the constituent elements and Ni concentration map. e) Histogram of intensities for the Ni distribution for a sputtered NiO thin film. The fit parameters and R<sup>2</sup> values for this Gaussian are reported. f) Convergence plots for each term in the cost function. Scale bar, 20 nm.

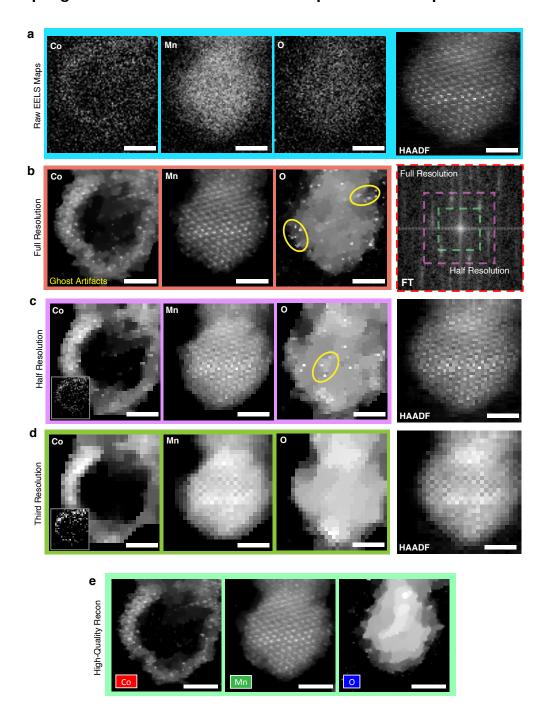
## 10 Uncertainty Maps for Synthetic CoS Recovery

## Standard Error (StdErr) Maps



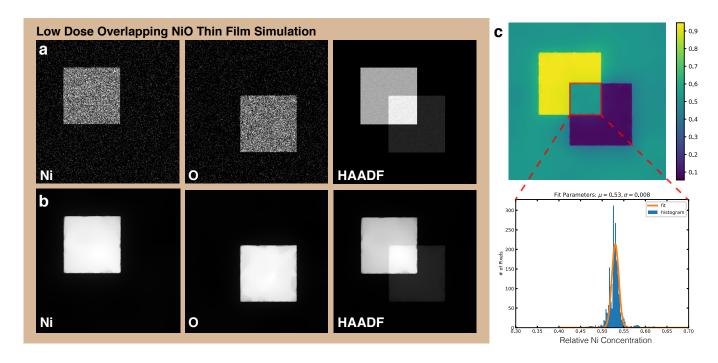
Supplementary Figure 10 | Visualization of the standard error (StdErr) maps for the synthetic CoS core shell simulation in Fig. 6b. As we increase the electron dose, the average StdErr pixel values for all three elements decreases.  $\langle \text{SNR} \rangle$  denotes the average SNR between the chemical and HAADF modality.

## 11 Downsampling Atomic Resolution Chemical Maps to Prevent Spurious Artifacts



Supplementary Figure 11 | Fused multi-modal electron microscopy at atomic-resolution requires attention for the appearance of spurious atoms. a-b) The raw EELS maps and the full resolution multi-modal reconstruction with spurious atom artifacts (circled yellow). The oxygen map, in particular, produces spurious atom artifacts due to weak oxygen signal in both the EELS and HAADF. The figure on the far right in (b) illustrates full and half resolution as the pixel size increases as the area reduces in Fourier space. (c) Reconstructing a half-resolution dataset suppresses a majority these ghost artifacts, however a few still remain (indicated in yellow). (d) If a third of the area is reconstructed, a frequency below which any Bragg peaks are present, we get a reliable lower resolution reconstruction. (e) A full resolution reconstruction can be achieved if the optimization begins using the results in (d) as an initial guess. Scale bar, 2 nm.

## 12 Synthetic NiO Reconstruction



Supplementary Figure 12 | a-b) Simulated and reconstructed Nickel, Oxygen and HAADF micrographs with concentrations inspired the experimental sputtered thin film. At low electron doses, TV regularization is unable to maintain the sharp edges. c) Ni ratio map and histogram of the overlapping region (indicated in red), the average concentration is  $\sim 53\%$ .

## References

1. Getreuer, P. Rudin-Osher-Fatemi Total Variation Denoising using Split Bregman. Image Processing On Line 2, 74–95 (2012).